

Ultra-small 7.8 m Ω 6 A Load Switch with Discharge

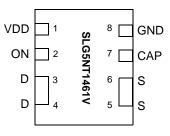
General Description

The SLG5NT1461V is a 7.8 m Ω 6 A single-channel load switch that is able to switch 0.85 to 5 V power rails. The product is packaged in an ultra-small 1.5 x 2.0 mm package.

Features

- 1.5 x 2.0 mm FC-TDFN 8L package (2 fused pins for drain and 2 fused pins for source)
- Logic level ON pin capable of supporting 0.85 V CMOS Logic
- User selectable ramp rate with external capacitor
- 7.8 mΩ RDS_{ON}while supporting 6 A
- · Discharges load when off
- Two Over Current Protection Modes
 - Short Circuit Current Limit
 - · Active Current Limit
- Over Temperature Protection
- Pb-Free / Halogen-Free / RoHS compliant
- Operating Temperature: -40 °C to 85°C
- Operating Voltage: 2.5 V to 5.5 V

Pin Configuration

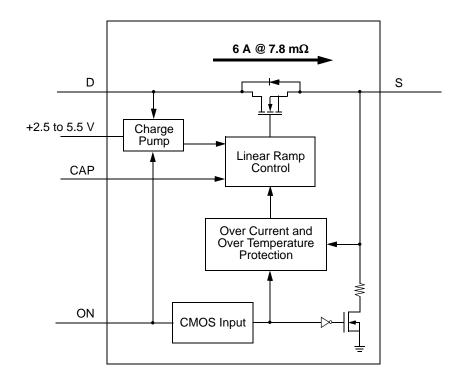


8-pin FC-TDFN (Top View)

Applications

- · Notebook Power Rail Switching
- Tablet Power Rail Switching
- · Smartphone Power Rail Switching

Block Diagram





Pin Description

Pin#	Pin Name	Туре	Pin Description			
1	VDD	PWR	VDD power for load switch control (2.5 V to 5.5 V)			
2	ON	Input	Turns MOSFET ON (4 M Ω pull down resistor) CMOS input with VIL < 0.3 V, VIH > 0.85 V			
3	D	MOSFET Drain of Power MOSFET (fused with pin 4)				
4	D	MOSFET	Drain of Power MOSFET (fused with pin 3)			
5	S	MOSFET	Source of Power MOSFET (fused with pin 6)			
6	S	MOSFET	Source of Power MOSFET (fused with pin 5)			
7	CAP	Input	Capacitor for controlling power rail ramp rate			
8	GND	GND	D Ground			

Ordering Information

Part Number	Туре	Production Flow
SLG5NT1461V	FC-TDFN 8L	Industrial, -40 °C to 85 °C
SLG5NT1461VTR	FC-TDFN 8L (Tape and Reel)	Industrial, -40 °C to 85 °C

000-005NT1461-102 Page 2 of 11



Absolute Maximum Ratings

Parameter	Description	Conditions	Min.	Тур.	Max.	Unit
V_{DD}	Power Supply				7	V
T _S	Storage Temperature		-65		150	°C
ESD _{HBM}	ESD Protection	Human Body Model	2000			V
ESD _{CDM}	ESD Protection	Charged Device Model	1000			V
MSL	Moisture Sensitivity Level			•		
$\theta_{\sf JA}$	Package Thermal Resistance, Junction-to-Ambient	1.5mm x 2mm 8L TDFN; Determined using 1 in ² , 1 oz. copper pads under each VD and VS terminals and FR4 pcb material		85		°C/W
W _{DIS}	Package Power Dissipation				1	W
MOSFET IDS _P	Peak Current from Drain to Source	For no more than 1 ms with 1% duty cycle			7	Α

Note: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Electrical Characteristics

 $T_A = -40 \, ^{\circ}\text{C}$ to 85 $^{\circ}\text{C}$ (unless otherwise stated)

Parameter	Description	Min.	Тур.	Max.	Unit	
V _{DD}	Power Supply Voltage	-40 °C to 85 °C	2.5		5.5	V
1	Dower Supply Current (DIN 1)	when OFF			1	μА
I _{DD}	Power Supply Current (PIN 1)	when ON, No load		70	100	μΑ
		T _A 25°C @ 100 mA		7.8	8.5	mΩ
RDS _{ON}	Static Drain to Source ON Resistance	T _A 70°C @ 100 mA		8.5	9.6	mΩ
		T _A 85°C @ 100 mA		11	12	mΩ
IDS	Operating Current	V _D = 0.85 V to 5.5 V			6	Α
V _D	Drain Voltage		0.85		V_{DD}	V
T _{ON_Delay}	ON pin Delay Time	50% ON to Ramp Begin, R_{LOAD} = 20 Ω, C_{LOAD} = 10 μF		300	500	μS
		50% ON to 90% V _S	Configurable ¹			ms
T _{Total_ON}	Total Turn On Time	Example: CAP (PIN 7) = 4 nF, V_{DD} = V_{D} = 5 V, Source_Cap = 10 μ F, R_{LOAD} = 20 Ω	1.6	1.96	2.4	ms
		10% V _S to 90% V _S	Co	onfigurable	e 1	V/ms
T _{SLEWRATE}	Slew Rate	Example: CAP (PIN 7) = 4 nF, V_{DD} = V_{D} = 5 V, Source_Cap = 10 μ F, R_{LOAD} = 20 Ω	2.4 3.0 3.6		3.6	V/ms
CAP _{SOURCE}	Source Cap	Source to GND			500	μF
R _{DIS}	Discharge Resistance		100	150	300	Ω
ON_V _{IH}	High Input Voltage on ON pin		0.85		V_{DD}	V
ON_V _{IL}	Low Input Voltage on ON pin		-0.3	0	0.3	V



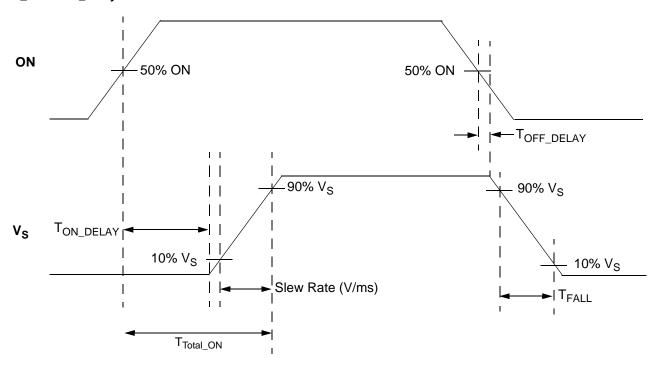
Electrical Characteristics (continued)

 $T_A = -40 \, ^{\circ}\text{C}$ to 85 $^{\circ}\text{C}$ (unless otherwise stated)

Description	Conditions	Min.	Тур.	Max.	Unit
Active Current Limit	MOSFET will automatically limit current when $V_S > 250 \text{ mV}$	6.0	7.0	9.0	Α
Short Circuit Current Limit	MOSFET will automatically limit current when V_{S} < 250 mV		0.5	1.0	Α
Thermal shutoff turn-on temperature			125	144	°C
Thermal shutoff turn-off temperature			100	115	°C
Thermal shutoff time				1	ms
OFF Delay Time	50% ON to V_S Fall, $V_{DD} = V_D = 5 V$; $R_{LOAD} = 20 \Omega$, no C_{LOAD}			15	μS
	Active Current Limit Short Circuit Current Limit Thermal shutoff turn-on temperature Thermal shutoff turn-off temperature Thermal shutoff time	Active Current Limit $\frac{\text{MOSFET will automatically limit current when V}_{\text{S}} > 250 \text{ mV}}{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}$ Thermal shutoff turn-on temperature $\frac{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}{\text{Thermal shutoff turn-off temperature}}$ Thermal shutoff time $\frac{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}$	Active Current Limit $\frac{\text{MOSFET will automatically limit current when V}_{\text{S}} > 250 \text{ mV}}{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}$ Short Circuit Current Limit $\frac{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}{\text{Thermal shutoff turn-on temperature}}$ Thermal shutoff turn-off temperature $\frac{\text{CFF Palou Times}}{\text{Thermal shutoff time}}$ 50% ON to V _S Fall, V _{DD} = V _D = 5 V;	Active Current Limit $\frac{\text{MOSFET}}{\text{will automatically limit current when V}_{\text{S}} > 250 \text{ mV}}$ 6.0 7.0 Short Circuit Current Limit $\frac{\text{MOSFET}}{\text{will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}$ 0.5 Thermal shutoff turn-on temperature $\frac{\text{MOSFET}}{\text{Thermal shutoff turn-off temperature}}$ 100 Thermal shutoff time $\frac{\text{MOSFET}}{\text{Soliculation}}$ 50% ON to $\frac{\text{V}_{\text{S}}}{\text{Fall}}$, $\frac{\text{V}_{\text{DD}}}{\text{DD}} = \frac{\text{V}_{\text{D}}}{\text{D}} = \frac{\text{V}_{\text{D}}}{\text{V}} = \frac{\text{V}_{\text{D}}}{\text{V}}$	Active Current Limit $\frac{\text{MOSFET will automatically limit current when V}_{\text{S}} > 250 \text{ mV}}{\text{MOSFET will automatically limit current when V}_{\text{S}} > 250 \text{ mV}} = 6.0 = 7.0 = 9.0$ Short Circuit Current Limit $\frac{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}}{\text{MOSFET will automatically limit current when V}_{\text{S}} < 250 \text{ mV}} =$

Notes:

${\bf T}_{{\sf Total_ON}}, {\bf T}_{{\sf ON_Delay}}$ and Slew Rate Measurement



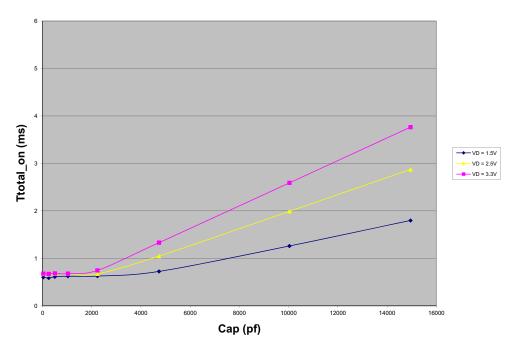
000-005NT1461-102 Page 4 of 11

^{1.} Refer to table for configuration details.



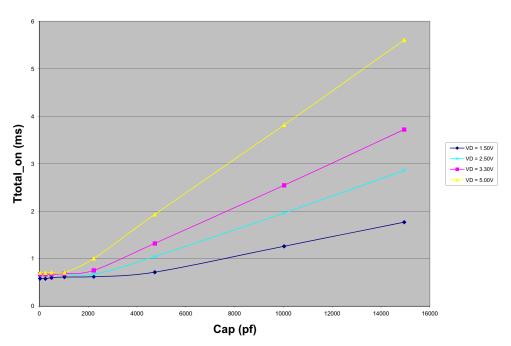
 T_{Total_ON} vs. CAP @ V_{DD} = 3.3 V

SLG5NT1461V T_{Total_ON}: ON (50%) - V_S (90%) V_{DD} = 3.3 V, T_A = 25 °C. C_L = 10 μ F, IDS = 100 mA



 $T_{Total\ ON}$ vs. CAP @ V_{DD} = 5.0 V

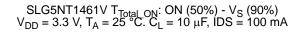
SLG5NT1461V T $_{\rm Total\ ON}$: ON (50%) - V $_{\rm S}$ (90%) V $_{\rm DD}$ = 5.0 V, T $_{\rm A}$ = 25 °C. C $_{\rm L}$ = 10 μF , IDS = 100 mA

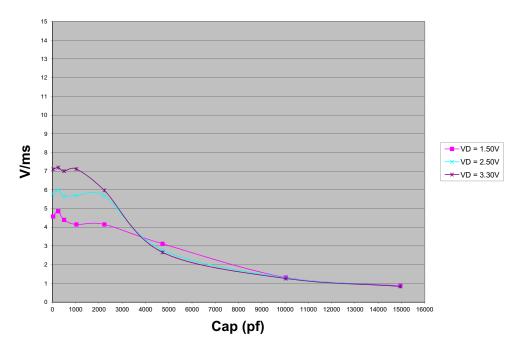


000-005NT1461-102 Page 5 of 11



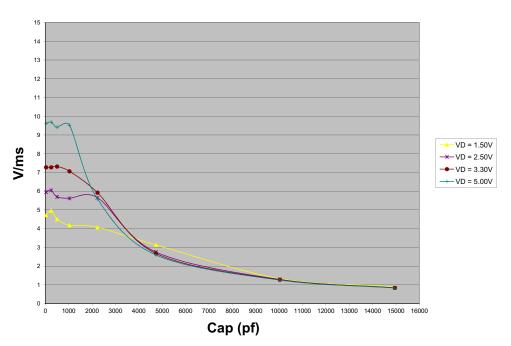
 T_{SLEW} vs. CAP @ V_{DD} = 3.3 V





 T_{SLEW} vs. CAP @ V_{DD} = 5.0 V

SLG5NT1461V T
$$_{Total\ ON}$$
: ON (50%) - V $_{S}$ (90%) V $_{DD}$ = 5.0 V, T $_{A}$ = 25 °C. C $_{L}$ = 10 μF , IDS = 100 mA



000-005NT1461-102 Page 6 of 11



SLG5NT1461V Turn ON

The normal power on sequence is first VDD, with VD only being applied after VDD is > 1 V, and then ON after VD is at least 90% of final value. The normal power off sequence is the power on sequence in reverse.

If VDD and VD are turned on at the same time then it is possible that a voltage glitch will appear on VS before VDD achieves 1V which is the VT of the main MOSFET. The size of the glitch is dependent on source and drain capacitance loading and the ramp rate of VDD & VD.

SLG5NT1461V Turn ON

The VS ramp follows a linear path, not an RC limitation provided the ramp is slow enough to not be current limited by load capacitance.

SLG5NT1461V Current Limiting

The SLG5NT1461V has two forms of current limiting.

7 A Standard Current Limiting Mode

Current is measured by mirroring the current through the main MOSFET. The mirrored current is then sent through a resistor creating a voltage V(i) proportional to the MOSFET current. The V(i) is then compared with a Band Gap voltage V(BG). If V(i) exceeds the Band Gap voltage then the voltage V(g) on the gate of the main MOSFET is reduced. The V(g) continues to drop until V(i) < V(BG). This response is a closed loop response and is therefore very fast and current limits in less than a few micro-seconds. There is no difference between peak or constant current limit.

Temperature Cutoff

However, as the V(g) drops the Rds(ON) of the main MOSFET will increase, thus limiting the current, but also increasing the power dissipation of the IC. The IC is very small and cannot dissipate much power. Therefore, if a current limit condition is sustained the IC will heat up. If the temperature exceeds approximately 120°C, then V(g) will be brought low completely shutting off the main MOSFET. As the die cools the MOSFET will be turned back on at 100°C.

If the current limiting condition has not been mitigated then the die will again heat up to 120°C and the process will repeat.

Short Circuit Current Limiting Mode

When V(S) < 250 mV, which is the case if there is a solder bridge during the manufacturing process or a hard short on the power rail, then the current is limited to approximately 500 mA. This current limit is accomplished in the same manner as the Standard Current Limiting Mode with the exception that the current mirror is 15x greater. Because the current mirror is so much larger, a 15x smaller main MOSFET current is required to generate the same V(i). If V(S) rises above approximately 250 mV, then this mode is automatically switched out.

000-005NT1461-102 Page 7 of 11



Package Top Marking System Definition

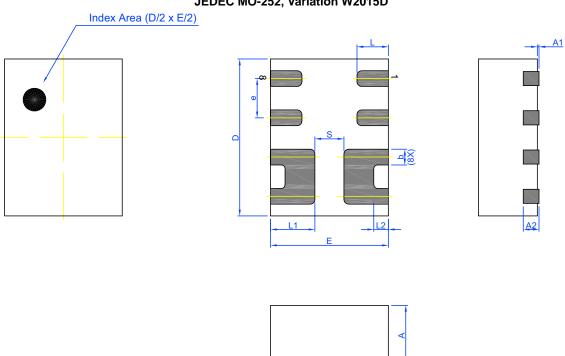
		XXA	Part Code + Assembly Site
Date Code + Revision		DDR	
Pin 1 Identifier	0	LL	Lot Traceability

000-005NT1461-102 Page 8 of 11



Package Drawing and Dimensions

8 Lead TDFN Package 1.5 x 2.0 mm (Fused Lead) JEDEC MO-252, Variation W2015D



Unit: mm

Symbol	Min	Nom.	Max	Symbol	Min	Nom.	Max
Α	0.70	0.75	0.80	L	0.35	0.40	0.45
A1	0.005	-	0.060	L1	0.515	0.565	0.615
A2	0.15	0.20	0.25	L2	0.135	0.185	0.235
b	0.15	0.20	0.25	е	(0.50 BSC	
D	1.95	2.00	2.05	S	0.37 REF		
E	1.45	1.50	1.55				

000-005NT1461-102 Page 9 of 11

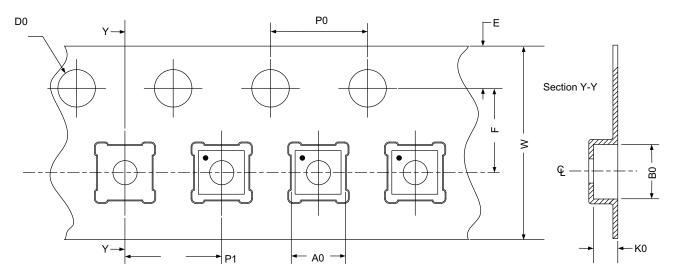


Tape and Reel Specifications

Package	# of	Nominal	Max	Max Units R		Leader (min)		Trailer (min)		Таре	Part
Туре	# OI Pins	Package Size [mm]	per Reel	per Box	er Box Hub Size [mm]	Pockets	Length [mm]	Pockets	Length [mm]	Width [mm]	Pitch [mm]
TDFN 8L FC Green	8	1.5 x 2.0 x 0.75	3000	3000	178 / 60	100	400	100	400	8	4

Carrier Tape Drawing and Dimensions

Package Type	PocketBTM Length	PocketBTM Width	Pocket Depth	Index Hole Pitch	Pocket Pitch	Index Hole Diameter	Index Hole to Tape Edge		Tape Width
	A0	В0	K0	P0	P1	D0	E	F	W
TDFN 8L FC Green	1.68	2.18	0.9	4	4	1.5	1.75	3.5	8



Refer to EIA-481 specification

Recommended Reflow Soldering Profile

Please see IPC/JEDEC J-STD-020: latest revision for reflow profile based on package volume of 2.25 mm³ (nominal). More information can be found at www.jedec.org.

000-005NT1461-102 Page 10 of 11



Revision History

Date	Version	Change
11/30/2015	1.02	Updated Max values in EC table Added Abs Max parameters

000-005NT1461-102 Page 11 of 11